

# PSF040R065B

650V 70A 38mΩ Si Super junction MOSFET with Fast Recovery Diode

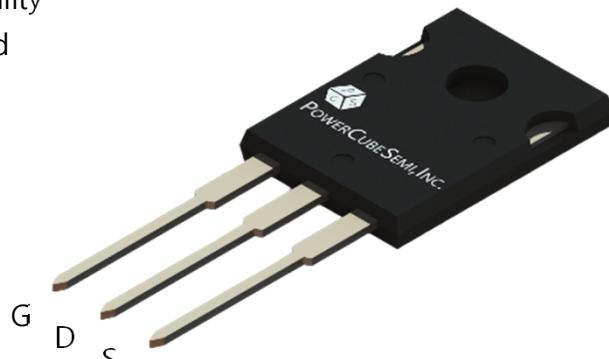


POWERCUBESEMI, INC.  
Potential · Convergence · Smart

## Features

### Si Super junction MOSFET

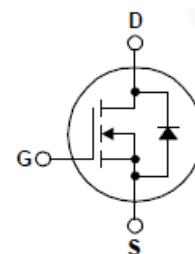
- Rated to 650V at 70Amps @ $T_J = 25^\circ\text{C}$
- Max  $R_{DS(on)} = 38 \text{ m}\Omega$
- Typ  $R_{DS(on)} = 34 \text{ m}\Omega$
- Improved dv/dt Capability
- 100% Avalanche Tested



PKG type : TO-247-3L

## Application

- Solar inverters
- LCD/LED/PDP TV
- Telecom/Server Power supplies
- AC-DC Power Supply



## Description

PSF040R065B is PowerCubeSemi's third generation of high voltage Super Junction MOSFET with FRD that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, the combination of Super Junction MOSFET with FRD is suitable for various AC/DC power conversion for system miniaturization and higher efficiency.

## Absolute Maximum Ratings

Symbol	Parameter	Test Condition	Value	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=1\text{mA}$	650	V
$I_D$	Drain Current	$T_c=25^\circ\text{C}$	70	A
$I_{DM}$	Pulsed Drain Current	Pulse width limited by junction temperature	230	A
$V_{GS}$	Gate-Source Voltage		$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy	$V_{DD}=230\text{V}, I_D=9.6\text{A}, R_G=25\Omega, L=50\text{mH}$	2264	mJ
$P_d$	Power Dissipation	$T_c=25^\circ\text{C}$	357	W
$T_J$	Operating Junction Temperature		150	$^\circ\text{C}$
$T_{stg}$	Storage Temperature		-55 to 150	$^\circ\text{C}$



## Package Marking and Ordering Information

Device Marking	Device	Package	Packing Method	Tape width	Quantity
PSF040R065B	PSF040R065	TO-247	TUBE	-	30

## Electrical Characteristics of Si MOSFET

Symbol	Parameter	Test Condition	Numerical			Unit
			Min	Typ.	Max.	
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=1mA, T_J = 25^\circ C$	650	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=650V, V_{GS}=0V$	-	-	10	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=1mA$	3	-	5	V
$R_{DS(ON)}$	Static Drain-Source on state resistance	$V_{GS}=10V, I_D=38A$ Pulse width=200 $\mu s$	-	34	38	$m\Omega$
$t_{d(on)}$	Turn-on Delay time	$V_{DD}=380 V, I_D=38A, V_{GS}=15 V, R_G=20\Omega$	-	43	-	ns
$T_r$	Turn-on Rise time		-	33	-	
$t_{d(off)}$	Turn-off Delay time		-	179	-	
$T_f$	Turn-off Fall time		-	18	-	



## Electrical Characteristics of Si MOSFET

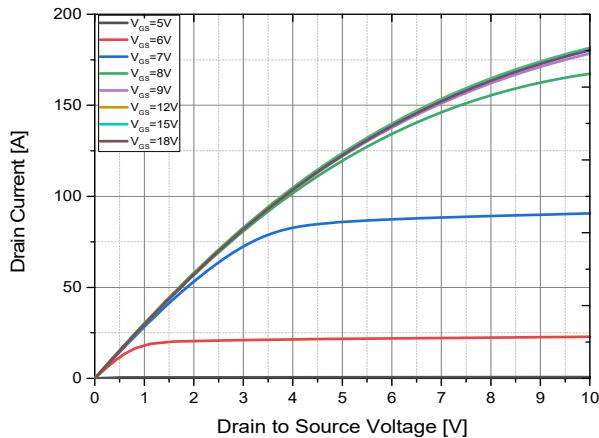
Symbol	Parameter	Test Condition	Numerical		Unit
			Typ.	Max.	
$R_{\theta JC}$	Thermal resistance, Junction to case		0.35	-	°C/W
$R_g$	Gate resistance	$V_{GS} = 0V, f = 1.0MHz$	3.0	-	Ω
$C_{iss}$	Input capacitance	$V_{DS} = 380V, V_{GS} = 0V, f = 1MHz$	6700	-	pF
$C_{oss}$	Output capacitance		95	-	
$C_{rss}$	Reverse transfer capacitance	$V_{DS} = 380V, V_{GS} = 0V, f = 200kHz$	15	-	
$Q_{g(tot)}$	Total gate charge at 10V	$V_{DS} = 380V, I_D = 38A, V_{GS(on)} = 10V$	150	-	nC
$Q_{gs}$	Gate to source gate charge		30	-	
$Q_{gd}$	Gate to drain "Miller" charge		60	-	

## Electrical Characteristics of Si Diode

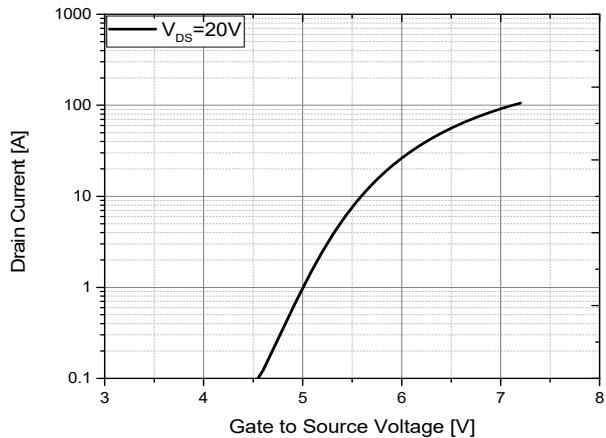
Symbol	Parameter	Test Condition	Numerical		Unit
			Typ.	Max.	
$I_S$	Maximum continuous drain to source diode forward current		-	70	A
$I_{SM}$	Maximum pulsed drain to source diode forward current		-	280	A
$V_{SD}$	Drain to source diode forward voltage	$I_{SD} = 38A, V_{GS} = 0V$	-	1.3	V
$T_{rr}$	Reverse recovery time	$I_F = 35A, V_{DS} = 400V, dI_F/dt=100A/\mu s$	229.7	-	ns
$I_{rr}$	Reverse recovery current		18.8	-	A
$Q_{rr}$	Reverse recovery charge		2.15	-	μC



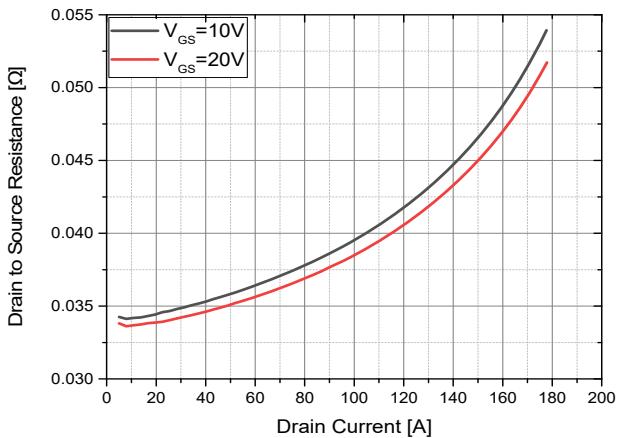
## Typical Characteristics



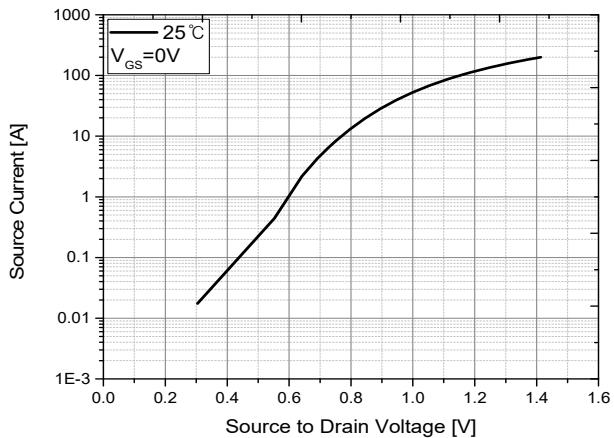
**Figure 1. On-state Characteristics**



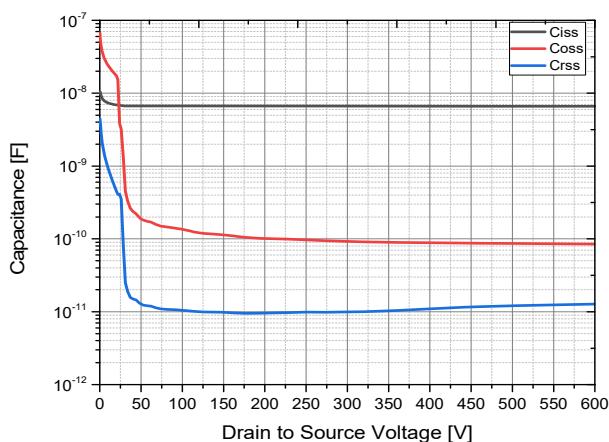
**Figure 2. Transfer Characteristics**



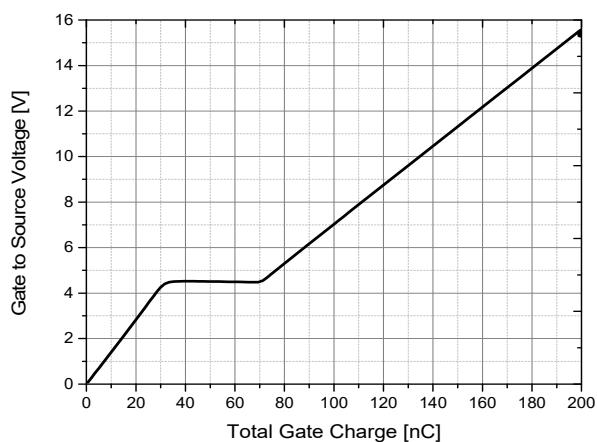
**Figure 3. On Resistance Variation vs Drain Current and Gate Voltage**



**Figure 4. Body Forward Voltage Variation vs Source Current and Temperature**

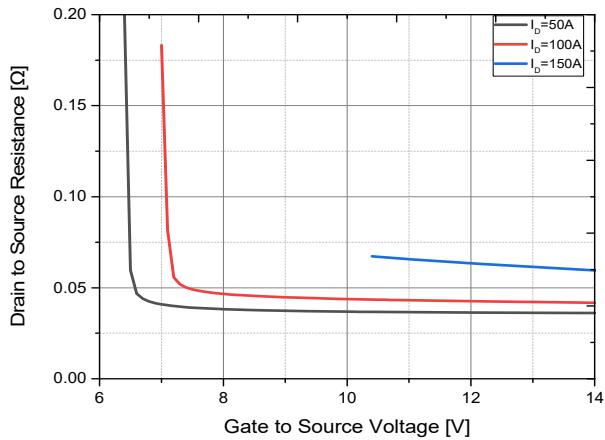


**Figure 5. Capacitance Characteristics**

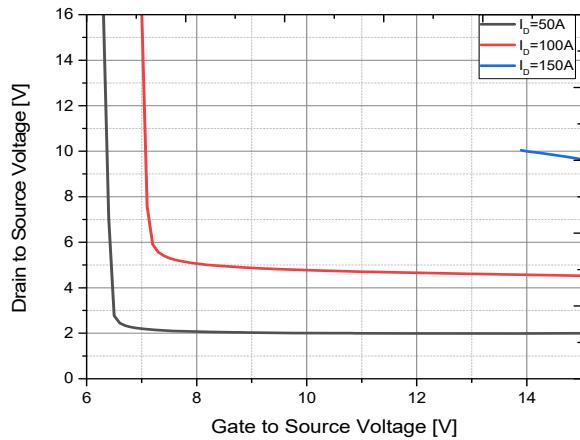


**Figure 6. Gate Charge Characteristics**

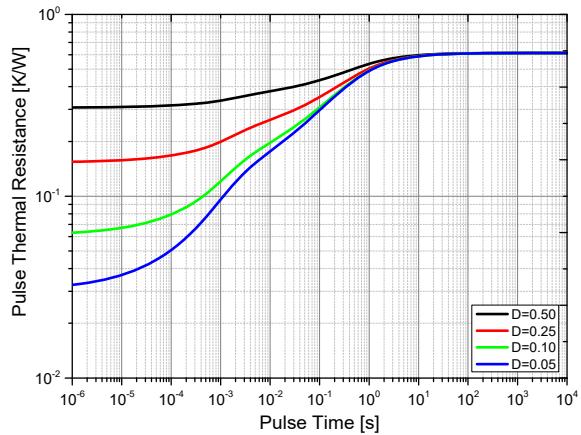
## Typical Characteristics



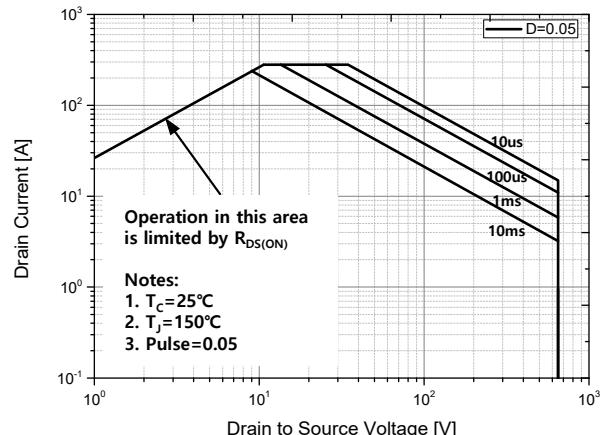
**Figure 7. Drain to Source Resistance vs Gate to Source Voltage**



**Figure 8. Drain to Source Voltage vs Gate to Source Voltage**



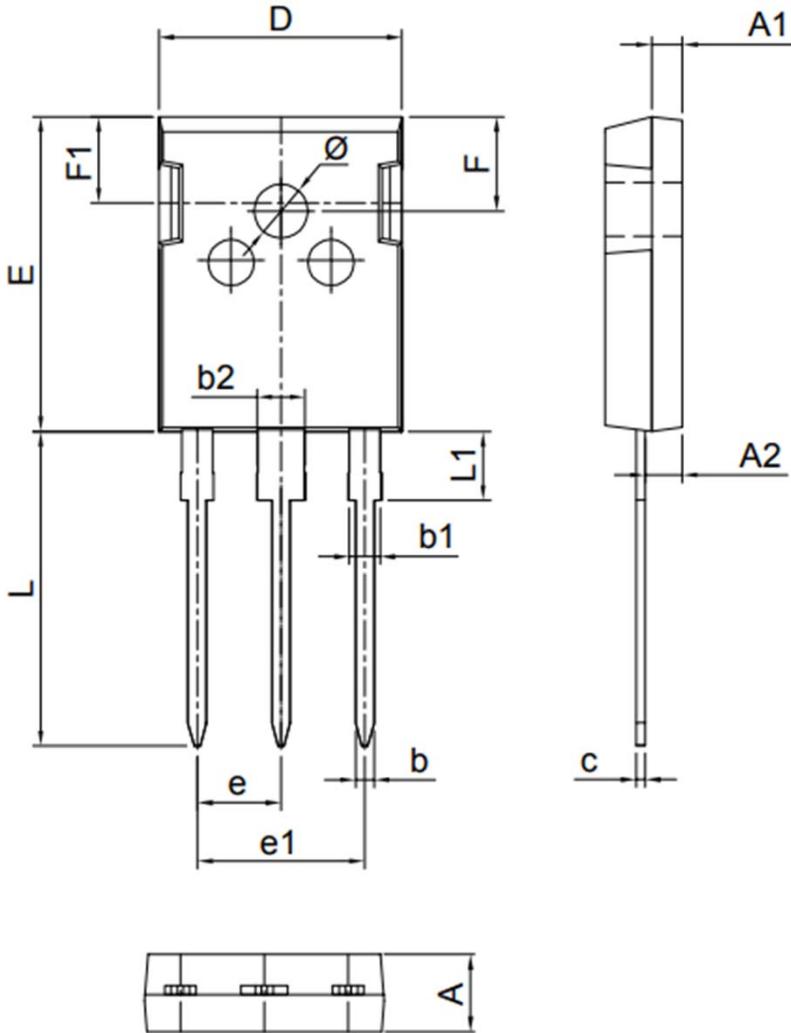
**Figure 9. Transient Thermal Response Curve**



**Figure 10. Safe Operating Area**



### Package Outline



Unit : mm

SYMBOL	DIMENSIONS		
	MIN	NOM	MAX
A	4.90	5.00	5.10
A1	1.90	2.00	2.10
A2	2.20	2.40	2.60
b	1.00	1.20	1.40
b1	2.00	2.10	2.20
b2	3.00	3.10	3.20
c	0.50	0.60	0.70
D	15.75	15.9	16.05
E	20.20	20.50	20.80
e		5.45	
e1		10.9	
F	6.05	6.15	6.25
F1	5.80	5.90	6.00
L	20.10	20.25	20.40
L1	4.05	4.20	4.35
Φ	3.50	3.60	3.70

## Revision History

Version	Data of release	Description of changes
pre	2024-01-30	Preliminary Datasheet
1.0	2024-04-12	Final Datasheet
1.1	2024-11-05	Update value of $T_{rr}$ & $I_{rr}$ & $Q_{rr}$
1.2	2025-04-08	Update value of IDM & Thermal Resistance and SOA Graph